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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/691,020	10/21/2003	Philip Neaves	501317.02 (30302/US)	4992
75	590 11/29/2005		EXAMINER	
Kimton N. Eng, Esq.			NGUYEN, TUNG X	
DORSEY & WHITNEY LLP Suite 3400 1420 Fifth Avenue			ART UNIT	PAPER NUMBER
			2829	
Seattle, WA 9	08101		DATE MAILED: 11/29/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	10/691,020	NEAVES ET AL.	
Office Action Summary	Examiner	Art Unit	
	Tung X. Nguyen	2829	
The MAILING DATE of this commu Period for Reply	nication appears on the cover	sheet with the correspondence ac	ddress
A SHORTENED STATUTORY PERIOD WHICHEVER IS LONGER, FROM THE I Extensions of time may be available under the provisior after SIX (6) MONTHS from the mailing date of this come If NO period for reply is specified above, the maximum Failure to reply within the set or extended period for reply received by the Office later than three months earned patent term adjustment. See 37 CFR 1.704(b).	MAILING DATE OF THIS CO as of 37 CFR 1.136(a). In no event, howe a numerication. It is statutory period will apply and will expire solve will, by statute, cause the application to	MMUNICATION. Iver, may a reply be timely filed SIX (6) MONTHS from the mailing date of this of the become ABANDONED (35 U.S.C. § 133).	
Status			
1) Responsive to communication(s) fi	led on <u>13 September 2005</u> .		
2a)⊠ This action is FINAL .	2b) ☐ This action is non-fine		•
3) Since this application is in condition	•	• •	e merits is
closed in accordance with the prac	tice under Ex parte Quayle, 1	935 C.D. 11, 453 O.G. 213.	
Disposition of Claims			
4) Claim(s) <u>25-32 and 44-47</u> is/are pe		ntion .	
4a) Of the above claim(s) is/5) Claim(s) is/are allowed.	are williarawii iroiii considera	AUOII.	
6)⊠ Claim(s) <u>25-32 and 44-47</u> is/are re	iected.		
7) Claim(s) is/are objected to.			
8) Claim(s) are subject to restr	iction and/or election requirer	nent.	
Application Papers		·	
9) ☐ The specification is objected to by t	he Examiner.		
10)☐ The drawing(s) filed on is/are		ected to by the Examiner.	
Applicant may not request that any obj	ection to the drawing(s) be held	in abeyance. See 37 CFR 1.85(a).	
Replacement drawing sheet(s) includir 11) The oath or declaration is objected	-	- '	
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a clain a) All b) Some * c) None of:	n for foreign priority under 35	U.S.C. § 119(a)-(d) or (f).	
	y documents have been rece	ived.	
2. Certified copies of the priorit	y documents have been rece	ived in Application No	
Copies of the certified copies	s of the priority documents ha	ave been received in this Nationa	l Stage
• •	ional Bureau (PCT Rule 17.2		
* See the attached detailed Office acti	ion for a list of the certified co	pies not received.	
Attach mont(c)			
Attachment(s) 1) Notice of References Cited (PTO-892)	4) 🗆	Interview Summary (PTO-413)	
2) D Notice of Draftsperson's Patent Drawing Review	(PTO-948)	Paper No(s)/Mail Date	CO 452)
3) Information Disclosure Statement(s) (PTO-1449 (Paper No(s)/Mail Date		Notice of Informal Patent Application (PT Other:	U-132)

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DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 25, 27, 29, 30, 32, 44, 46-47 are rejected under 35 U.S.C. 103(a) as being unpatentable over Cilingiroglu (u.s.p 5,124,660), in view of Parker et al. (u.s.p 6,097,203).

As to claims 25, 30, Cilingiroglu disclose in Figs. 1-5, a method for evaluating an integrated circuit (110 of figure 1) having a plurality of data terminals (112 of figure 1) at which data signals are received, the method comprising: capacitively coupling a test plate (106 of figure 1) to a plurality of data terminals (112 of figure 1) at which data signals are received; transmitting a data signal from the test plate to one of the plurality of data terminals (col. 3, lines 31-47); and evaluating the data signal detected by at the data terminal against a test criteria (col. 3, lines 31-47). Cilingiroglu does not teach or suggest the test plate integrated in the integrated circuit. However, Parker et al disclose a test plate (614 of figure 6A) integrated in the integrated circuit (col. 3, lines 25-35) for enabling continuity testing the package or integrated circuit. Therefore, It would have been obvious to a person having ordinary skill in the art at the time the invention to modify the system of Cilingiroglu, and provide the test plate integrated in the integrated

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circuit, as taught by Parker et al for enabling continuity testing the package or integrated circuit.

As to claim 27, Cilingiroglu disclose in Figs. 1-5, ceasing reception of the data signal from the first signal terminal (via 516 of figure 5); transmitting a data signal from the test plate to another one of the plurality of signal terminals (via 516 of figure 5); and evaluating the data signal detected by other signal terminal against the test criteria (col. 5, lines 30-40).

As to claim 29, Cilingiroglu disclose in Figs. 1-5, decoupling the test plate (106 of figure 1, 502-504 of figure 5) from a voltage reference (via 518) and coupling the test plate (502-504 of figure 5) to a transmitting circuit generating a test signal in response to detecting an input test signal (col. 3, lines 31-47).

As to claim 32, Cilingiroglu discloses in Figs. 1-5, evaluating detected data signal comparing the detected data signal to an expected data signal (col. 3, lines 35-47).

As to claim 44, Cilingiroglu disclose in Figs. 1-5, a test apparatus for an integrated circuit (500 of figure 5, or 110 of figure 1) having plurality of capacitively coupled signal terminals (501 of figure 5) to which a corresponding plurality of receivers are coupled, the receivers generating a respective data signal in response to detecting a respective input data signal (col. 5, lines 30-40), the test apparatus comprising: a test plate (501 of figure 5) to capacitively couple to the signal terminals of the integrated circuit (500 of figure 5); a test transmitter circuit (516, 518 of figure 5) coupled to the test plate (501 of figure 5) to transmit a data signal to at least one of the signal terminals through the test plate (col. 5, lines 30-40); and a test unit (522 of figure 5) coupled to the

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test signal terminals to evaluate the detected data signal against test criteria (col. 5, lines 30-40).

As to claim 46, Cilingiroglu disclose in Figs. 1-5, the test unit (522 of figure 5) comprising test circuitry to determine the functionality of the receivers coupled to the signal terminals and the integrity of a capacitor through which the signal terminal is capacitively coupled (col. 5, lines 30-40).

As to claim 47, Cilingiroglu disclose in Figs. 1-5, the test unit comprises test circuitry to compare the detected data signal against an expected data signal (col. 5, lines 30-40);

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claim 26 is rejected under 35 U.S.C. 103(a) as being unpatentable over Cilingiroglu (u.s.p 5,124,660), in view of Parker et al. (u.s.p 6,097,203); and further in view of Vest et al. (u.s.p 6,242,941).

As to claim 26, Cilingiroglu in view of Parker et al discloses in Figs. 1-5, all of the limitations except for placing the remaining data terminals of the plurality in a high-impedance state. However, Vest et al. disclose in col. 1, lines 63-67, the terminals of the plurality in a high-impedance state for reducing noise in the testing mode. Therefore, It would have been obvious to a person having ordinary skill in the art at the time the

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invention was made to modify the system of Cilingiroglu in view of Parker et al, and provides the terminals of plurality in high-impedance state, as taught by Vest et al., for reducing noise in the testing mode (col. 1, lines 63, 67).

As to claim 28, Cilingirolu discloses in Figs. 1-5, all of the limitations except for forming the test plate from a conductive plate layer formed on the semiconductor die. However, Parker et al. disclose in Figs. 6A, forming the test plate (614 of figure 6A) from a conductive plate layer formed on the semiconductor die (600 of figure 6A) for effectively testing the electrical continuity between the paths of integrated circuit (see the abstract). Therefore, It would have been obvious to a person having ordinary skill in the art at the time the invention was made to modify the system of Cilingiroglu, and provide the test plate from a conductive plate layer formed on the semiconductor die, as taught by Parker et al, for effectively testing the electrical continuity between the paths of integrated circuit (see the abstract).

As to claim 31, Cilingirolu discloses in Figs. 1-5, the integrated circuit comprising a memory device (110 of figure 1).

5. Claim 45 is rejected under 35 U.S.C. 103(a) as being unpatentable over Cilingiroglu (u.s.p 5,124,660); in view of Parker et al. (u.s.p 6,097,203); and further in view of Seki (u.s.p 6,714,031).

As to claim 45, Cilingiroglu in view of Parker et al. discloses in Figs. 1-5, all of the limitations except for the test transmitter comprising a buffer circuit. However, Seki disclose in Figs. 6, the test transmitter comprising a buffer circuit (61 of figure 6) for delaying in each stage (col. 6, lines 40-45). Therefore, It would have been obvious to a

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person having ordinary skill in the art at the time the invention was made to modify a system of Cilingiroglu in view of Parker et al, and provide the buffer circuit, as taught by Seki for delaying in each stage (col. 6, lines 40-45).

Response to Arguments

6. Applicant's arguments with respect to claims 25-32, and 44-47 have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tung X. Nguyen whose telephone number is (571) 272-1967. The examiner can normally be reached on 8:30am-5:00pm M-F.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nestor Ramirez can be reached on (571) 272-2034. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

TN 11/22/05

VINH NGUYÉN PRIMARY EXAMINER

A.u. 2829